Search Notes					

Application/Centrel No.	Applicant(s)/Patent under Reexamination		
10/665,056	JIN ET AL.		
Examiner	Art Unit		
Apu M. Mofiz	2165		

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Subclass	Date	Examiner
3,5,6,7,	06/08/05	Br.
104:1		
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	3,5,6,7, 10,102, 104:1 301 224,271 531	3,5,6,7, 06/08/08 10,102, 104:1 301 224,272

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
707	3	02/5/06	An		
707	5	02/15/06	An		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE		EXMR	
Inventar Sent	04/08/01		Au	
EZAT - USPAPUS - COJJP3 - LBM TOB - DERWOWT				
NPL -Acm - IEEE				
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